QUAD CHANNEL M-LVDS RECEIVERS

Check for Samples: SN65MLVD048

FEATURES

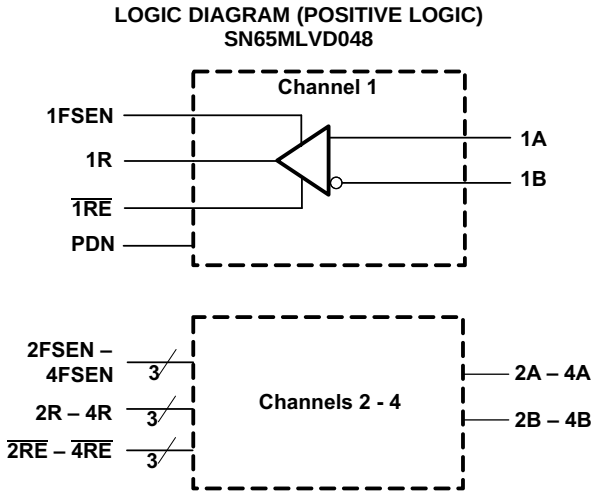
- **Low-Voltage Differential 30-Ω to 55-Ω Line Receivers for Signaling Rates(1) up to 250Mbps; Clock Frequencies up to 125MHz**
- **Type-1 Receiver Incorporates 25 mV of Input Threshold Hysteresis**
- **Type-2 Receiver Provides 100 mV Offset Threshold to Detect Open-Circuit and Idle-Bus Conditions**
- **Wide Receiver Input Common-Mode Voltage Range, –1 V to 3.4 V, Allows 2 V of Ground Noise**
- **Meets or Exceeds the M-LVDS Standard TIA/EIA-899 for Multipoint Topology**
- **High Input Impedance when V_{cc} ≤ 1.5V**
- **Enhanced ESD Protection: 7 kV HBM on all pins**
- **48-Pin 7 X 7 QFN (RGZ)**

(1) The signaling rate of a line is the number of voltage transitions that are made per second, expressed in the units bps (bits per second).

APPLICATIONS

- **Parallel Multipoint Data and Clock Transmission via Backplanes and Cables**
- **Cellular Base Stations**
- **Central Office Switches**
- **Network Switches and Routers**

LOGIC DIAGRAM (POSITIVE LOGIC)



DESCRIPTION

The SN65MLVD048 is a quad-channel M-LVDS receiver. This device is designed in full compliance with the TIA/EIA-899 (M-LVDS) standard, which is optimized to operate at signaling rates up to 250 Mbps. Each receiver channel is controlled by a receive enable ($\overline{RE}$). When $\overline{RE}$ = low, the corresponding channel is enabled; when $\overline{RE}$ = high, the corresponding channel is disabled.

The M-LVDS standard defines two types of receivers, designated as Type-1 and Type-2. Type-1 receivers have thresholds centered about zero with 25 mV of hysteresis to prevent output oscillations with loss of input; Type-2 receivers implement a failsafe by using an offset threshold. Receiver outputs are slew rate controlled to reduce EMI and crosstalk effects associated with large current surges.

The devices are characterized for operation from –40°C to 85°C.

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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of the Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

PIN FUNCTIONS

PIN		I/O	DESCRIPTION
NAME	NO.		
1R—4R	36, 33, 29, 26	O	Data output from receivers
1A–4A	47, 3, 9, 13	I/O	M-LVDS bus non-inverting input/output
1B–4B	48, 4, 10, 14	I/O	M-LVDS bus inverting input/output
GND	6, 7, 18, 23, 27, 31, 34, 38, 43	I	Circuit ground. **ALL GND pins must be connected to ground.**
V_{CC}	2, 11, 15, 16, 24, 37, 45, 46	I	Supply voltage. **ALL VCC pins must be connected to supply.**
$\overline{1RE}$–$\overline{4RE}$	40, 42, 19, 21	I	Receiver enable, active low, enables individual receivers. When this pin is left floating, internally this pin will be pulled to logic HIGH.
1FSEN–4FSEN	39, 41, 20, 22	I	Failsafe enable pin. When this pin is left floating, internally this pin will be pulled to logic HIGH. This pin enables the Type 2 receiver for the respective channel. xFSEN = L → Type 1 receiver inputs xFSEN = H → Type 2 receiver inputs
PDN	30		Power Down pin. When this pin is left floating, internally this pin will be pulled to logic LOW. When PDN is HIGH, the device is powered up. When PDN is LOW, the device overrides all other control and powers down. All outputs are Hi-Z
NC	1, 5, 8, 12, 17, 25, 28, 32, 35		Not Connected
NC	44		Not Connected. Internal TI Test pin. **This pin must be left unconnected.**
PowerPAD™	–		Connected to GND

RGZ PACKAGE
(TOP VIEW)

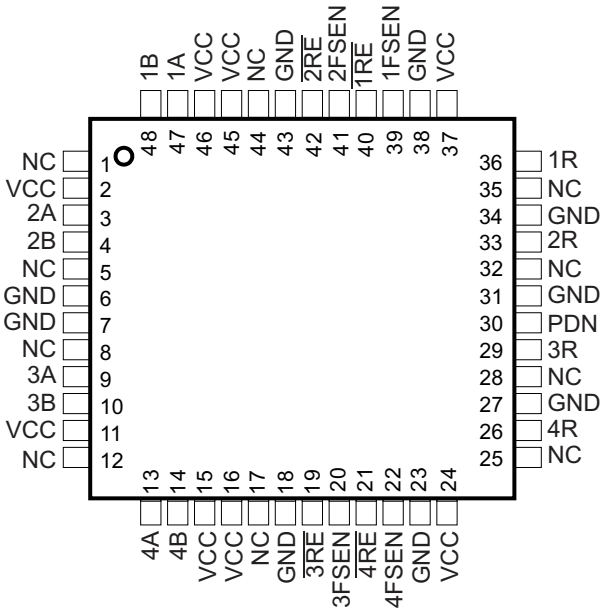

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Table 1. DEVICE FUNCTION TABLE

INPUTS[1]				RECEIVER TYPE	OUTPUT[1]
$V_{ID} = V_A - V_B$	PDN	FSEN	$\overline{RE}$		R
V_{ID} > 35 mV	H	L	L	Type 1	H
–35 mV ≤ V_{ID} ≤ 35 mV	H	L	L	Type 1	?
V_{ID} < – 35 mV	H	L	L	Type 1	L
V_{ID} > 135 mV	H	H	L	Type 2	H
65 mV ≤ V_{ID} ≤ 135 mV	H	H	L	Type 2	?
V_{ID} < 65 mV	H	H	L	Type 2	L
Open Circuit	H	L	L	Type 1	?
Open Circuit	H	H	L	Type 2	L
X	H	X	H	X	Z
X	H	X	OPEN	X	Z
X	L	X	X	X	Z

(1) H=high level, L=low level, Z=high impedance, X=Don't care, ?=indeterminate

ORDERING INFORMATION[1]

PART NUMBER	FUNCTION	PART MARKING	PACKAGE / CARRIER
SN65MLVD048RGZR	M-LVDS Type 1 and 2 Receiver	MLVD048	48-Pin QFN / Tape and Reel
SN65MLVD048RGZT		MLVD048	48-Pin QFN / Small Tape and Reel

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

PACKAGE DISSIPATION RATINGS[1]

PACKAGE	PCB TYPE	T_A ≤ 25°C POWER RATING	DERATING FACTOR[2] ABOVE T_A = 25°C	T_A = 85°C POWER RATING
48-Pin QFN (RGZ)	Low-K	1298 mW	12.98 mW/°C	519 mW
	High-K	3448 mW	34.48 mW/°C	1379 mW

(1) The thermal dissipations are in the consideration of soldering down the powerPAD without via on each type of boards.
(2) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

THERMAL CHARACTERISTICS

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JB}$	Junction-to-board thermal resistance			9		°C/W
$R_{\theta JC}$	Junction-to-case thermal resistance			20		°C/W
$R_{\theta JP}$	Junction-to-pad thermal resistance			1.37		°C/W
P_D	Device power dissipation	$\overline{RE}$ at 0 V, C_L = 15 pF, V_{ID} = 400 mV, 125 MHz			339	mW

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ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) (1)

				VALUE	UNIT
V_{CC}	Supply voltage range(2)			–0.5 to 4	V
	Input voltage range	$\overline{RE}$, FSEN		–0.5 to 4	V
		A or B		–1.8 to 4	V
	Output voltage range	R		–0.3 to 4	V
	Electrostatic discharge	Human-body model(3)	All other pins	±7	kV
		Charged-device model(4)	All pins	±1.5	kV

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.
(3) Tested in accordance with JEDEC Standard 22, Test Method A114-E. Bus pin stressed with respect to a common connection of GND and V_{CC}.
(4) Tested in accordance with EIA-JEDEC JESD22-C101D.

RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	3	3.3	3.6	V
V_{IH}	High-level input voltage	2		V_{CC}	V
V_{IL}	Low-level input voltage	GND		0.8	V
V_A or V_B	Voltage at any bus terminal	–1.4		3.8	V
$\|V_{ID}\|$	Magnitude of differential input voltage	0.05		V_{CC}	V
V_{IC}	Differential common-mode input voltage	–1		3.4	V
R_L	Differential load resistance	30	50		Ω
$1/t_{UI}$	Signaling rate			250	Mbps
T_A	Operating free-air temperature	–40		85	°C

DEVICE ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP(1)	MAX	UNIT
I_{CC}	Supply current	$\overline{RE}$ at 0 V for all channels C_L = 15 pF, V_{ID} = 400 mV, 125 MHz		86	94	mA
	Power down	PDN = L		0.75	1.5	mA

(1) All typical values are at 25°C and with a 3.3-V supply voltage.

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RECEIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP(1)	MAX	UNIT
V_{IT+}	Positive-going differential input voltage threshold	Type 1	See Table 2 and Table 3			35	mV
		Type 2				135	
V_{IT-}	Negative-going differential input voltage threshold	Type 1		–35			mV
		Type 2		65			
V_{HYS}	Differential input voltage hysteresis ($V_{IT+} – V_{IT-}$)	Type 1			25		mV
		Type 2			0		
V_{OH}	High-level output voltage		I_{OH} = –8 mA	2.4			V
V_{OL}	Low-level output voltage		I_{OL} = 8 mA			0.4	V
I_{IH}	High-level input current		V_{IH} = 2 V to V_{CC}	–10			µA
I_{IL}	Low-level input current		V_{IL} = GND to 0.8 V	–10			µA
I_{OZ}	High-impedance output current		V_O = 0 V or V_{CC}	–10		15	µA
I_A or I_B	Receiver input current		One input (V_A or V_B) = –1.4 V or 3.8 V, Other input = 1.2 V	–20		20	µA
I_{AB}	Receiver differential input current ($I_A – I_B$)		$V_A = V_B$ = –1.4 V or 3.8 V	–4		4	µA
$I_{A(OFF)}$ or $I_{B(OFF)}$	Receiver input current		One input (V_A or V_B) = –1.4 V or 3.8 V, Other input = 1.2 V, V_{CC} = GND or 1.5 V	–32		32	µA
$I_{AB(OFF)}$	Receiver power-off differential input current ($I_A – I_B$)		$V_A = V_B$ = –1.4 V or 3.8 V, V_{CC} = GND or 1.5 V	–4		4	µA
C_A or C_B	Input capacitance		V_I = 0.4sin(30E6πt) + 0.5V,(2) Other input at 1.2 V		5		pF
C_{AB}	Differential input capacitance		V_{AB} = 0.4sin(30E6πt) + 0.5 V(2)			3	pF
$C_{A/B}$	Input capacitance balance, (C_A/C_B)			0.99		1.01	

(1) All typical values are at 25°C and with a 3.3-V supply voltage.
(2) HP4194A impedance analyzer (or equivalent)

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RECEIVER SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP(1)	MAX	UNIT
t_{PLH}	Propagation delay time, low-to-high-level output		C_L = 15 pF, See Figure 2	2		6	ns
t_{PHL}	Propagation delay time, high-to-low-level output			2		6	ns
t_r	Output signal rise time			1		2.3	
t_f	Output signal fall time			1		2.3	ns
$t_{sk(p)}$	Pulse skew ($\lvert t_{PHL} - t_{PLH} \rvert$)	Type 1			35	270	ps
		Type 2			150	460	
$t_{sk(pp)}$	Part-to-part skew					800	ps
$t_{jit(per)}$	Period jitter, rms (1 standard deviation)(2)		All channels switching, 125 MHz clock input(3), See Figure 4			6	ps
$t_{jit(c-c)}$	Cycle-to-cycle jitter, rms(2)					13	ps
$t_{jit(det)}$	Deterministic jitter(2)	Type 1	All channels switching, 250 Mbps 2^{15}-1 PRBS input(3), See Figure 4			800	ps
		Type 2				945	ps
$t_{jit(ran)}$	Random jitter(2)	Type 1				9	ps
		Type 2				8	ps
t_{PZH}	Enable time, high-impedance-to-high-level output		C_L = 15 pF, See Figure 3			15	ns
t_{PZL}	Enable time, high-impedance-to-low-level output		C_L = 15 pF, See Figure 3			15	ns
t_{PHZ}	Disable time, high-level-to-high-impedance output		C_L = 15 pF, See Figure 3			10	ns
t_{PLZ}	Disable time, low-level-to-high-impedance output		C_L = 15 pF, See Figure 3			10	ns

(1) All typical values are at 25°C and with a 3.3-V supply voltage.
(2) Jitter is ensured by design and characterization. Stimulus jitter has been subtracted from the numbers.
(3) $t_r = t_f$ = 0.5ns (10% to 90%)

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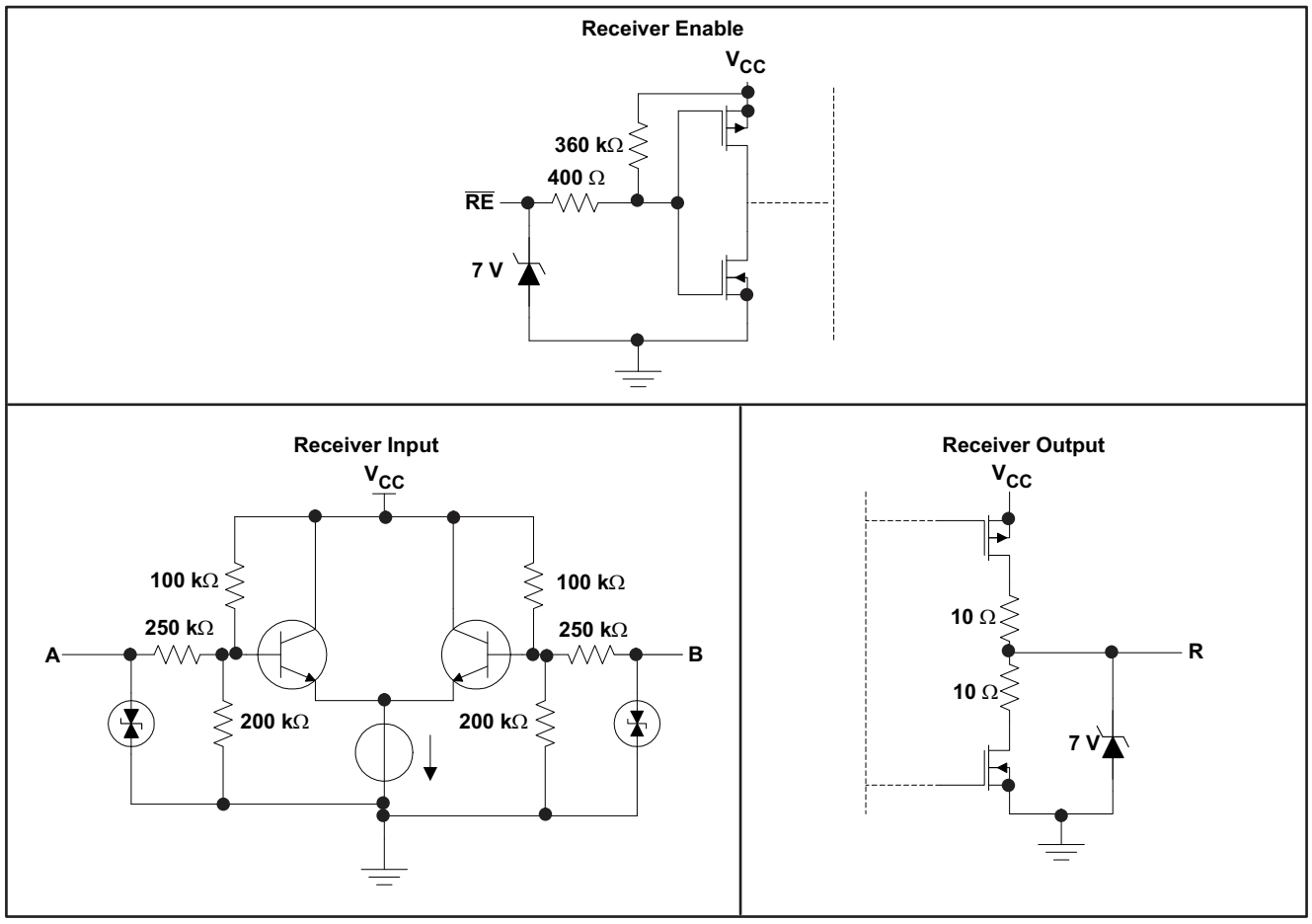
EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



PARAMETER MEASUREMENT INFORMATION

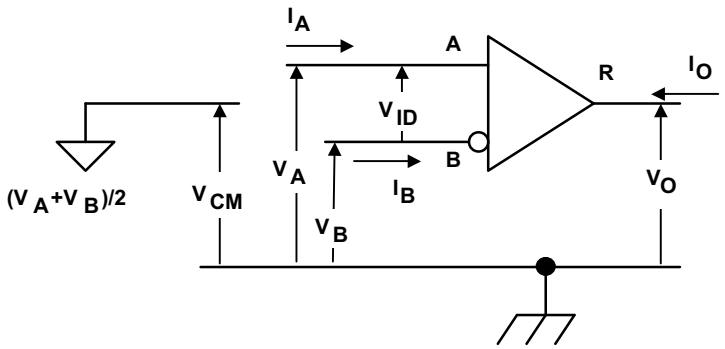


Figure 1. Receiver Voltage and Current Definitions

Table 2. Type-1 Receiver Input Threshold Test Voltages

APPLIED VOLTAGES		RESULTING DIFFERENTIAL INPUT VOLTAGE	RESULTING COMMON-MODE INPUT VOLTAGE	RECEIVER OUTPUT(1)
V_{IA}	V_{IB}	V_{ID}	V_{IC}	
2.400	0.000	2.400	1.200	H
0.000	2.400	–2.400	1.200	L
3.400	3.365	0.035	3.3825	H
3.365	3.400	–0.035	3.3825	L
–0.965	–1	0.035	–0.9825	H
–1	–0.965	–0.035	–0.9825	L

(1) H= high level, L = low level, output state assumes receiver is enabled ($\overline{RE}$ = L)

Table 3. Type-2 Receiver Input Threshold Test Voltages

APPLIED VOLTAGES		RESULTING DIFFERENTIAL INPUT VOLTAGE	RESULTING COMMON-MODE INPUT VOLTAGE	RECEIVER OUTPUT(1)
V_{IA}	V_{IB}	V_{ID}	V_{IC}	
2.400	0.000	2.400	1.200	H
0.000	2.400	–2.400	1.200	L
3.400	3.265	0.135	3.3325	H
3.4000	3.335	0.05065	3.3675	L
–0.865	–1	0.135	–0.9325	H
-0.935	–1	0.065	–0.9675	L

(1) H= high level, L = low level, output state assumes receiver is enabled ($\overline{RE}$ = L)

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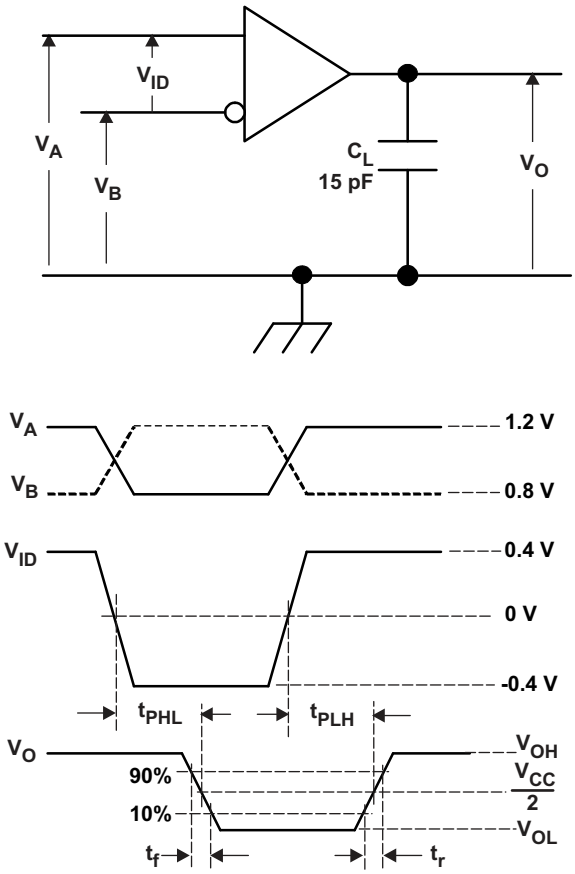
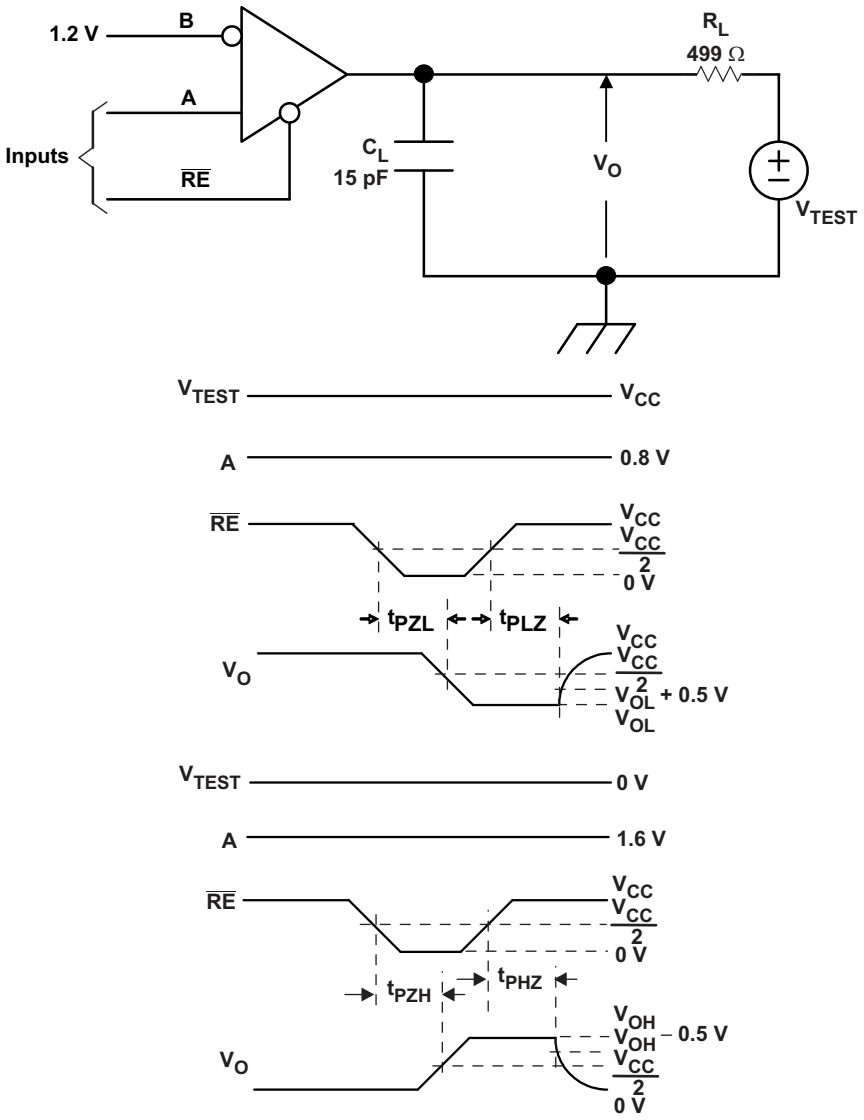


A. All input pulses are supplied by a generator having the following characteristics: t_r or t_f ≤ 1 ns, Frequency = 1 MHz, duty cycle = 50 ± 5%. C_L is a combination of a 20%-tolerance, low-loss ceramic, surface-mount capacitor and fixture capacitance within 2 cm of the D.U.T.

B. The measurement is made on test equipment with a –3dB bandwidth of at least 1 GHz.

Figure 2. Receiver Timing Test Circuit and Waveforms



A. All input pulses are supplied by a generator having the following characteristics: t_r or t_f ≤ 1 ns, frequency = 1 MHz, duty cycle = 50 ± 5%.

B. R_L is 1% tolerance, metal film, surface mount, and located within 2 cm of the D.U.T

C. C_L is the instrumentation and fixture capacitance within 2 cm of the D.U.T. and ±20%. The measurement is made on test equipment with a –3dB bandwidth of at least 1GHz.

Figure 3. Receiver Enable/Disable Time Test Circuit and Waveforms

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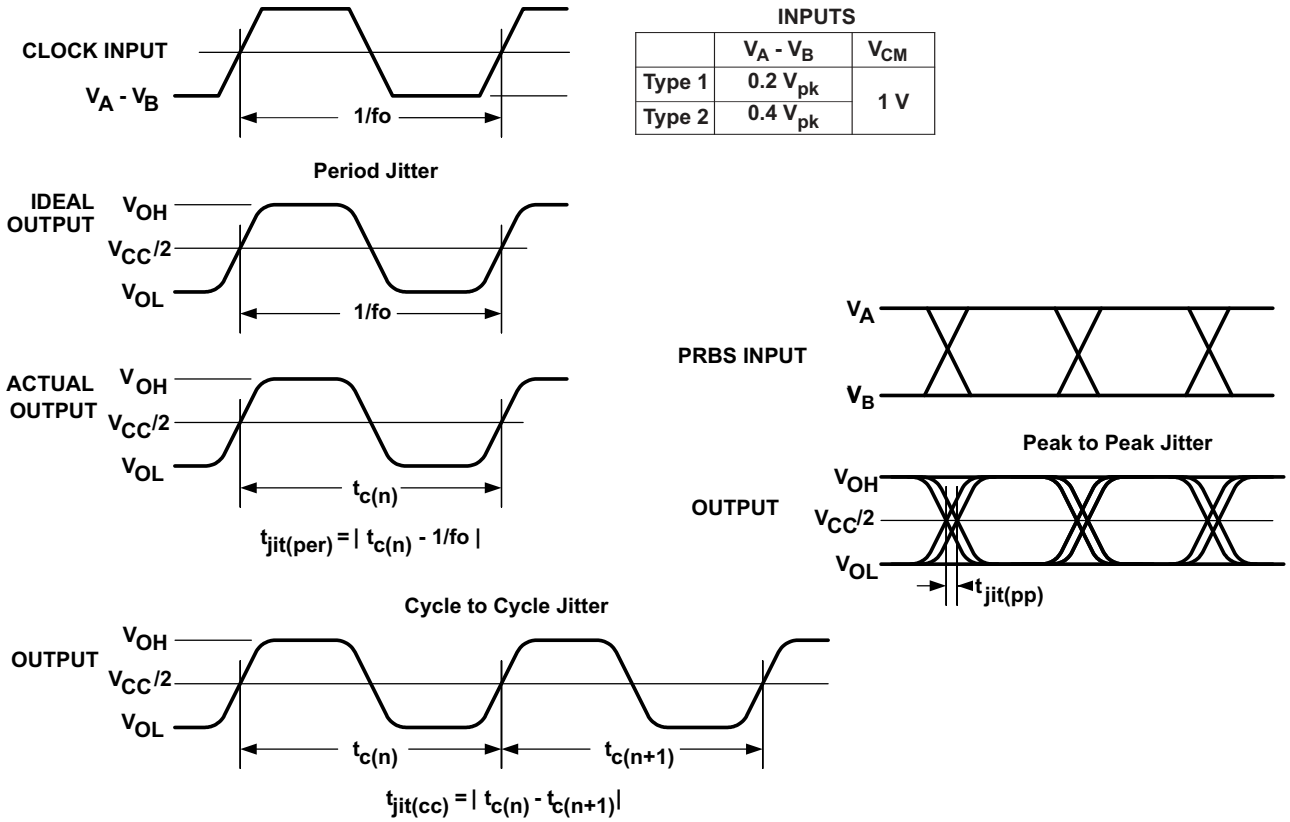

A. All input pulses are supplied by the Agilent 81250 Parallel BERT Stimulus System with plug-in E4832A.

B. The cycle-to-cycle jitter measurement is made on a TEK TDS6604 running TDSJIT3 application software.

C. All other jitter measurements are made with an Agilent Infiniium DCA-J 86100C Digital Communications Analyzer.

D. Period jitter and cycle-to-cycle jitter are measured using a 125-MHz 50 ± 1% duty cycle clock input. Measured over 75K samples.

E. Deterministic jitter and random jitter are measured using a 250-Mbps $2^{15\ -1}$ PRBS input. Measured over BER = $10^{\ -12}$

Figure 4. Receiver Jitter Measurement Waveforms

TYPICAL CHARACTERISTICS

SUPPLY CURRENT
vs
FREQUENCY

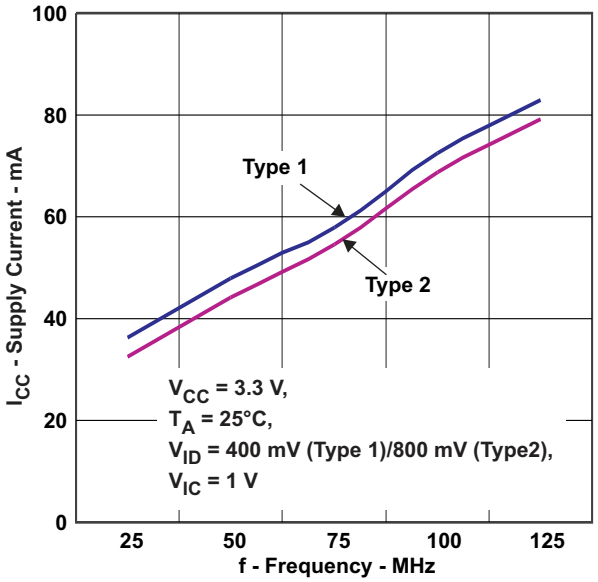

Figure 5.

RECEIVER (TYPE-1) PROPAGATION DELAY TIME
vs
FREE-AIR TEMPERATURE

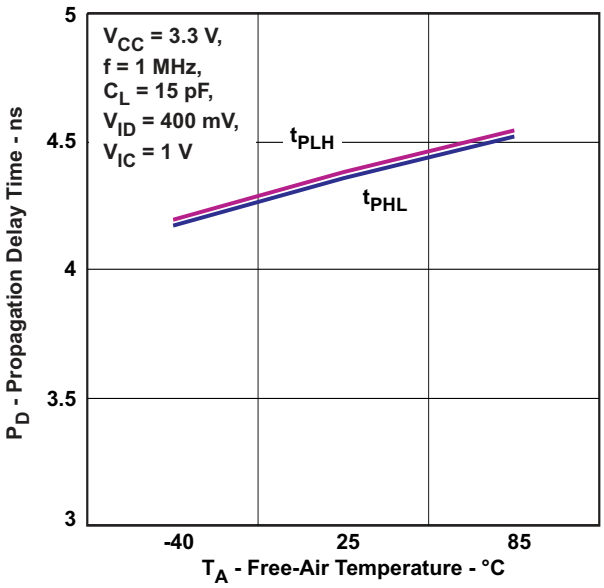

Figure 6.

RECEIVER (TYPE-2) PROPAGATION DELAY TIME
vs
FREE-AIR TEMPERATURE

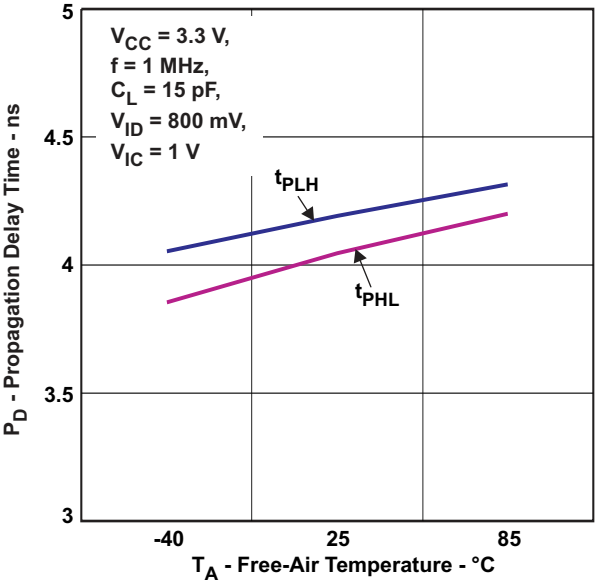

Figure 7.

RECEIVER (TYPE-1) TRANSITION TIME
vs
FREE-AIR TEMPERATURE

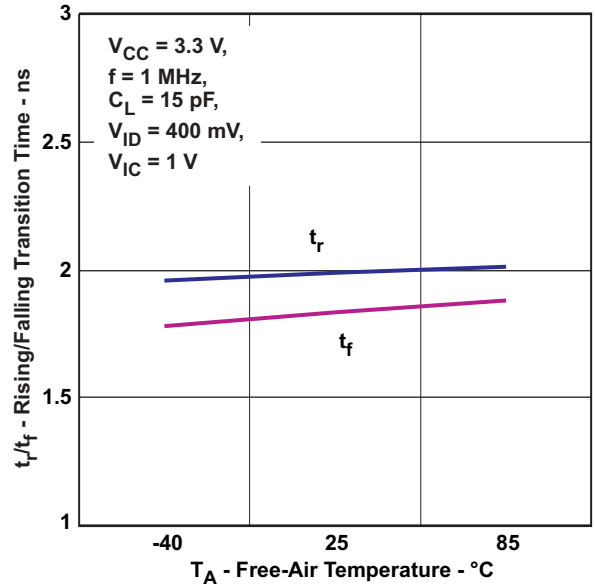

Figure 8.

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TYPICAL CHARACTERISTICS (continued)

RECEIVER (TYPE-2) TRANSITION TIME
vs
FREE-AIR TEMPERATURE

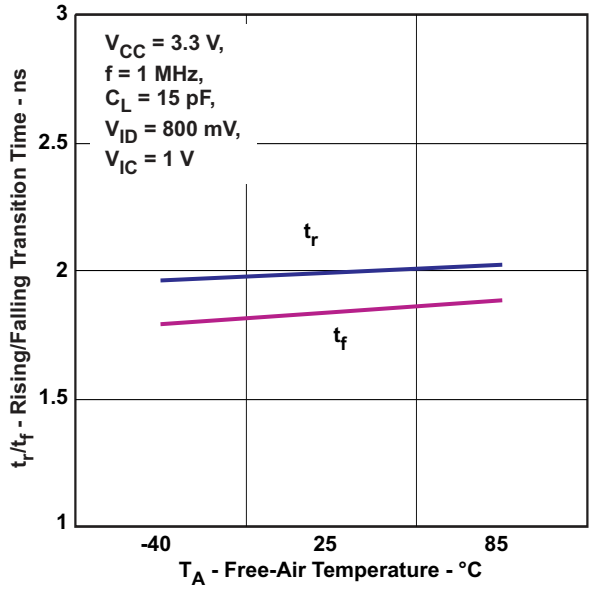

Figure 9.

RECEIVER (TYPE-1) TRANSITION TIME
vs
OUTPUT LOAD CAPACITOR

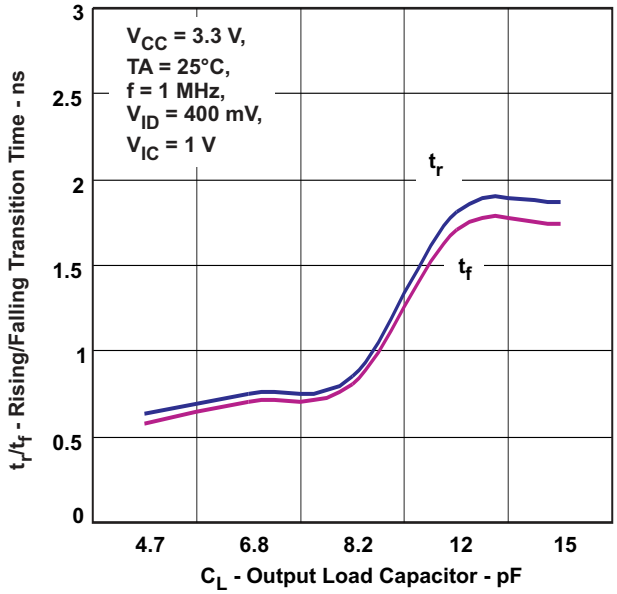

Figure 10.

RECEIVER (TYPE-2) TRANSITION TIME
vs
OUTPUT LOAD CAPACITOR

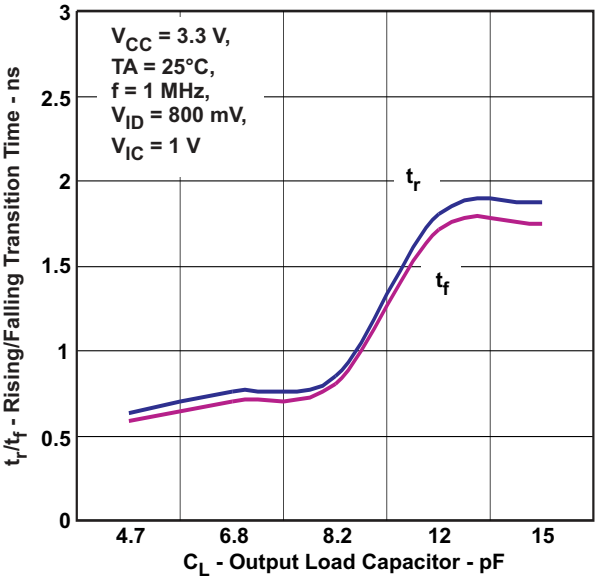

Figure 11.

ADDED RECEIVER PEAK-TO-PEAK JITTER
vs
SIGNALING RATE

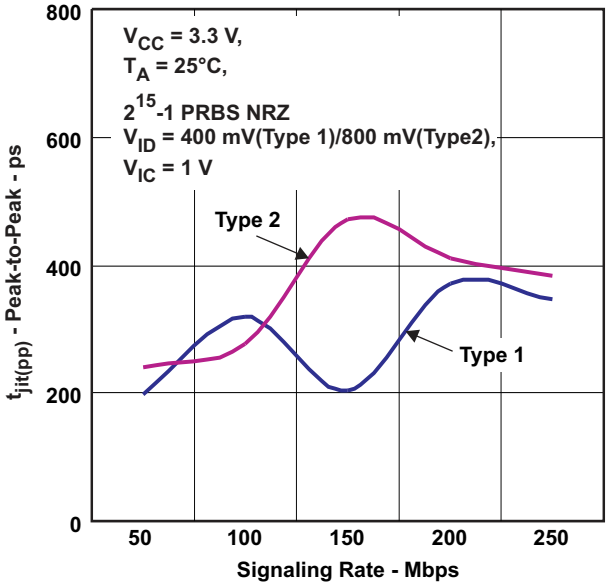

Figure 12.

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TYPICAL CHARACTERISTICS (continued)

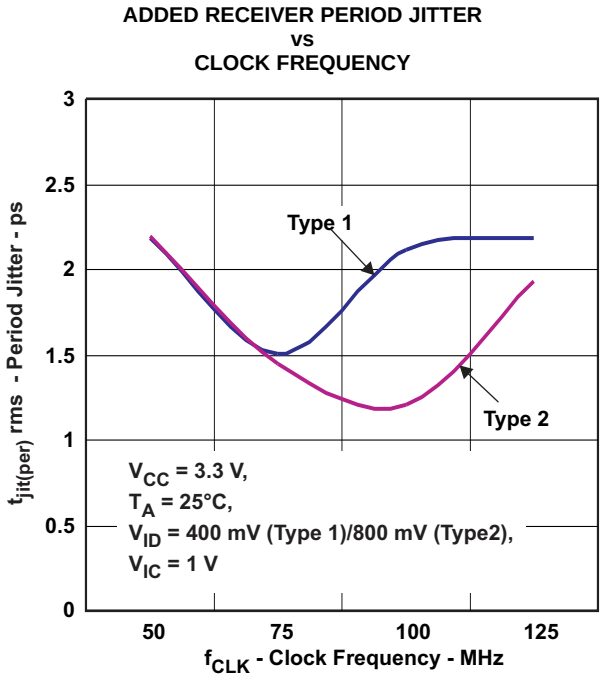

Figure 13.

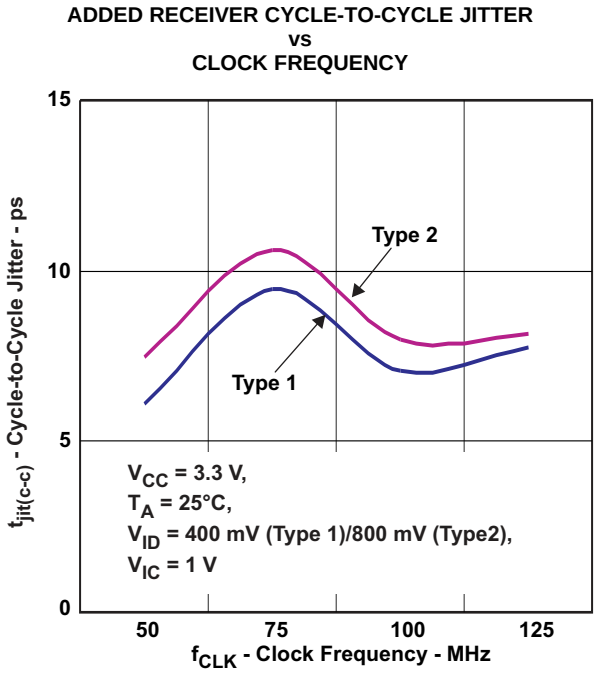

Figure 14.

EYE PATTERNS

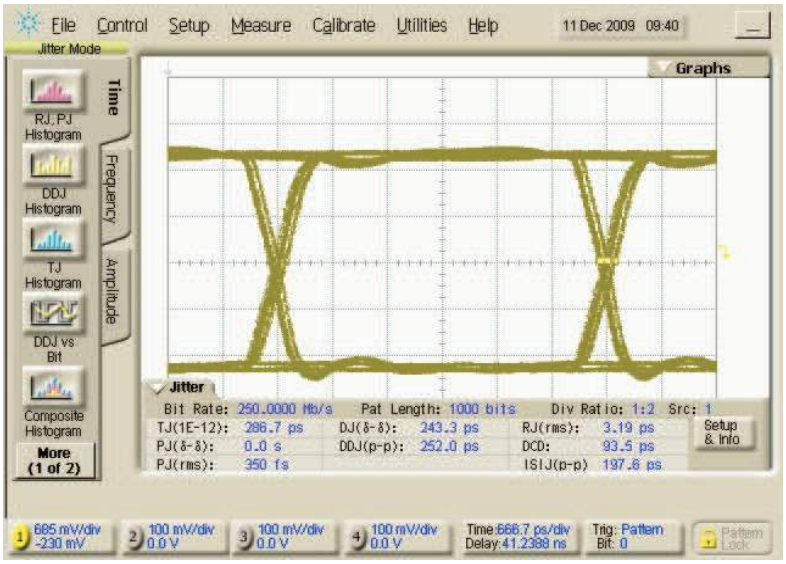

Figure 15. SN65MLVD048 Output (V_{CC} = 3.3 V, V_{ID} = 400 mV) 250 Mbps 2^{15}–1 PRBS, Receiver Type 1

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TYPICAL CHARACTERISTICS (continued)

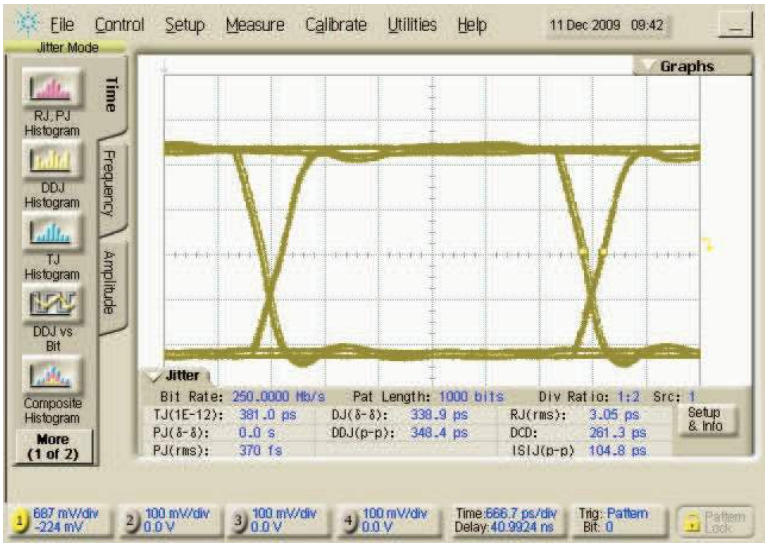

Figure 16. SN65MLVD048 Output (V_{CC} = 3.3 V, V_{ID} = 800 mV) 250 Mbps 2^{15}–1 PRBS, Receiver Type 2

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN65MLVD048RGZR	ACTIVE	VQFN	RGZ	48	2500	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	MLVD048	Samples
SN65MLVD048RGZT	ACTIVE	VQFN	RGZ	48	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 85	MLVD048	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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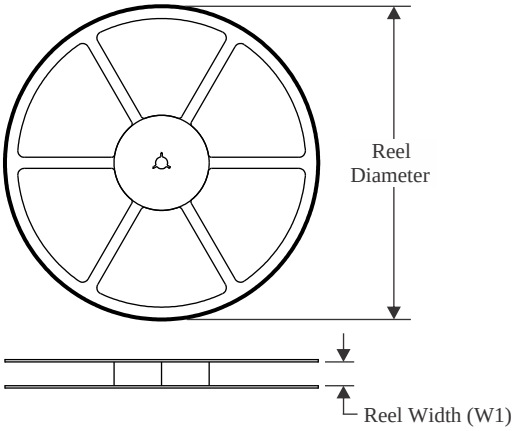
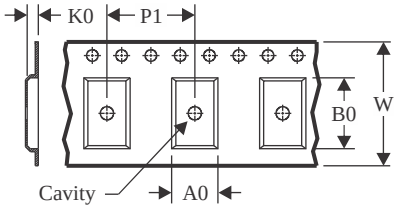
TAPE AND REEL INFORMATION

REEL DIMENSIONS

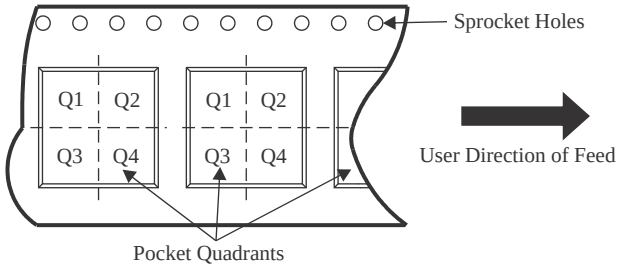


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

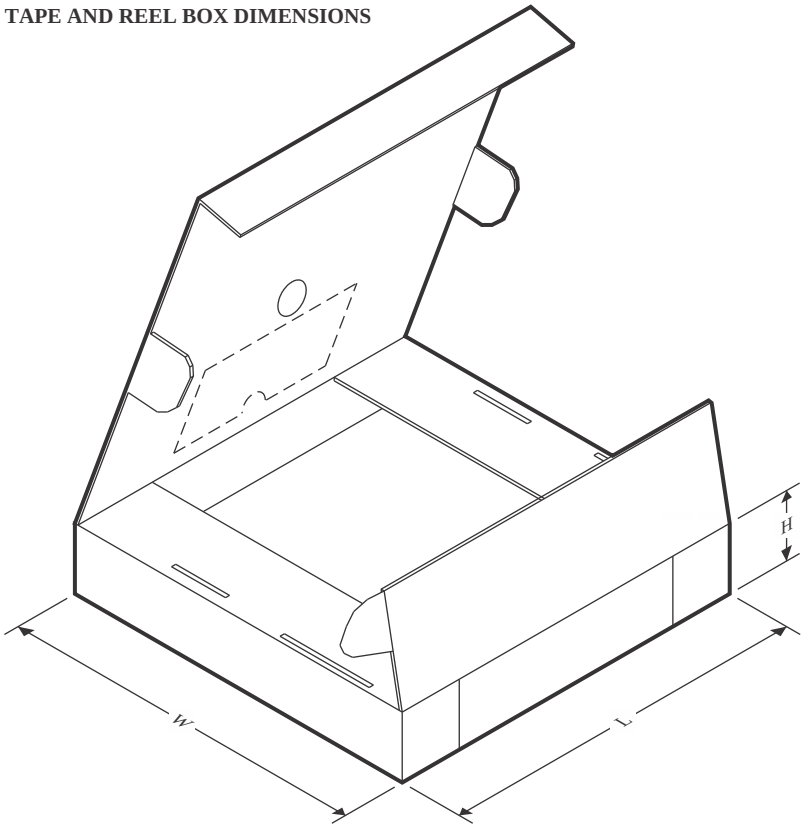
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65MLVD048RGZR	VQFN	RGZ	48	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2
SN65MLVD048RGZT	VQFN	RGZ	48	250	180.0	16.4	7.3	7.3	1.5	12.0	16.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65MLVD048RGZR	VQFN	RGZ	48	2500	356.0	356.0	35.0
SN65MLVD048RGZT	VQFN	RGZ	48	250	210.0	185.0	35.0

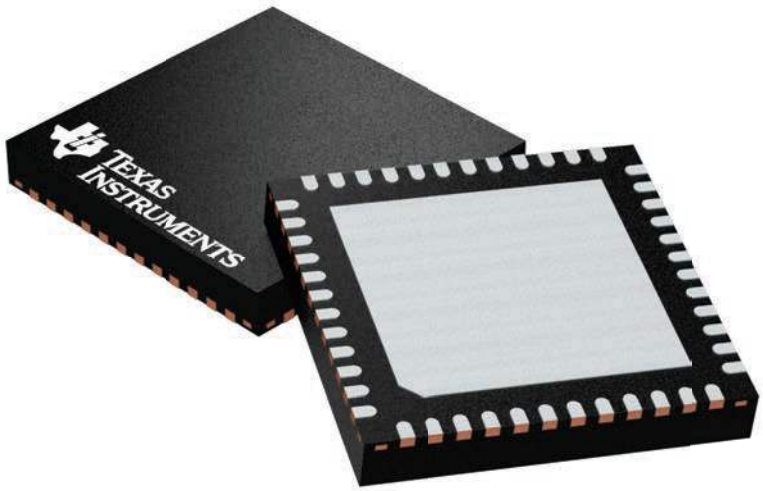
GENERIC PACKAGE VIEW

RGZ 48

VQFN - 1 mm max height

7 x 7, 0.5 mm pitch

PLASTIC QUADFLAT PACK- NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

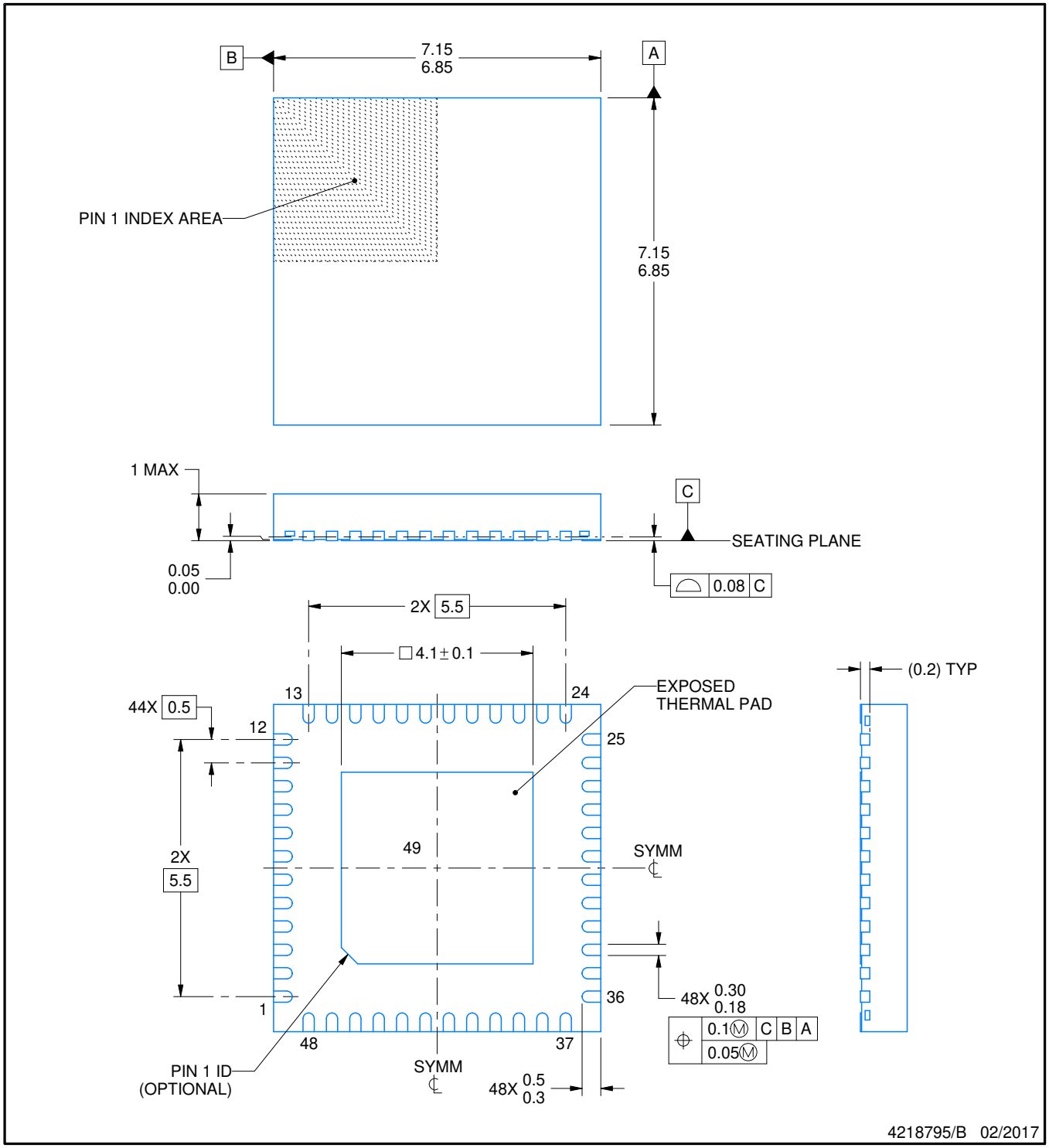
4224671/A

RGZ0048B

PACKAGE OUTLINE

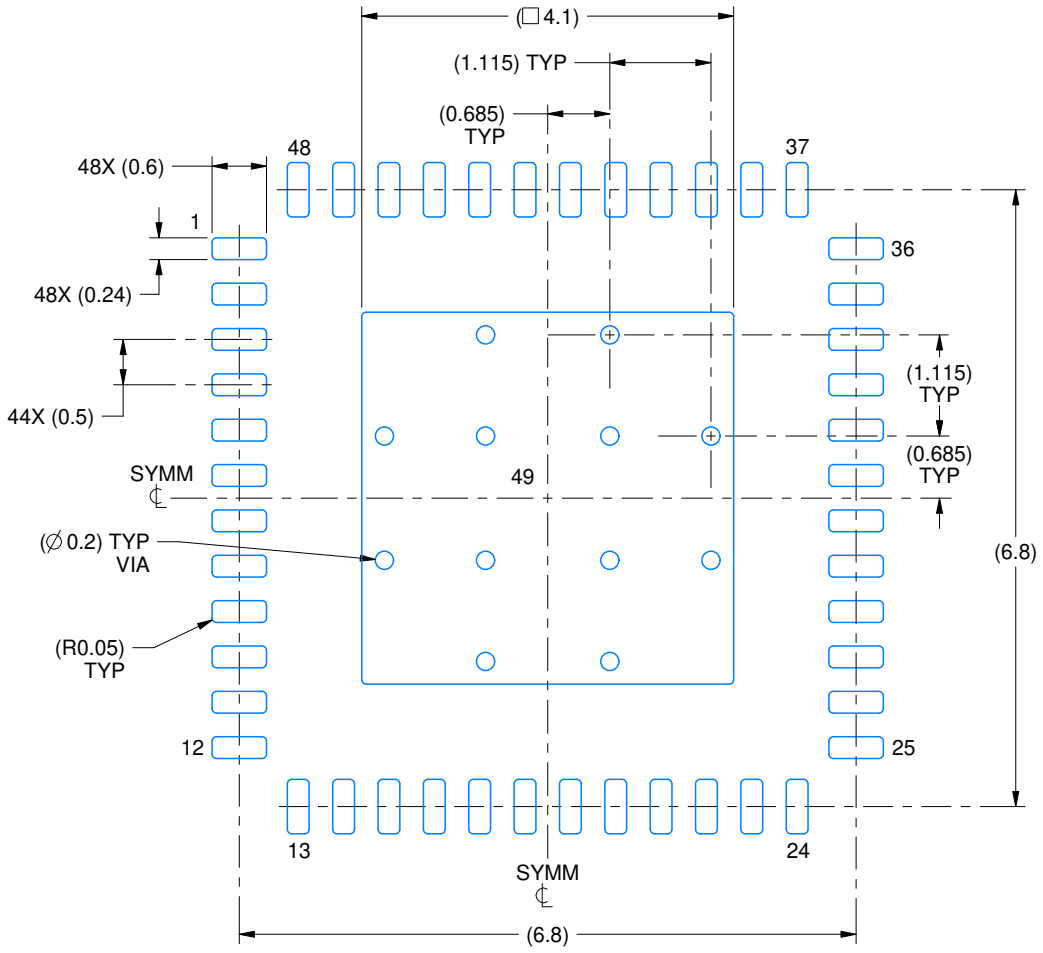
VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

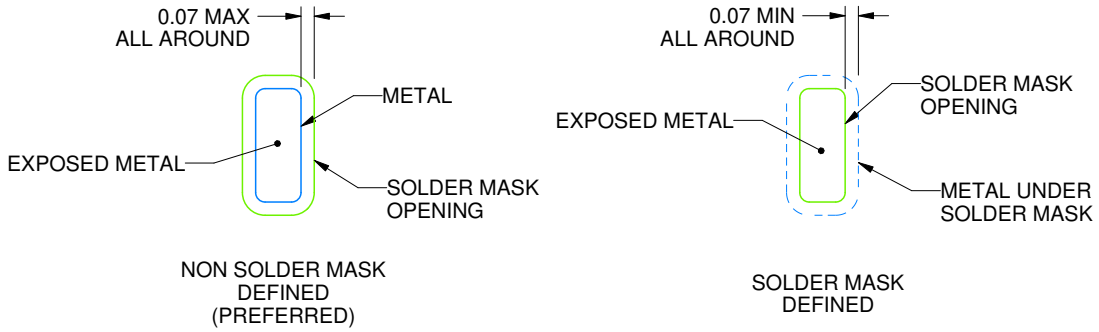


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:12X

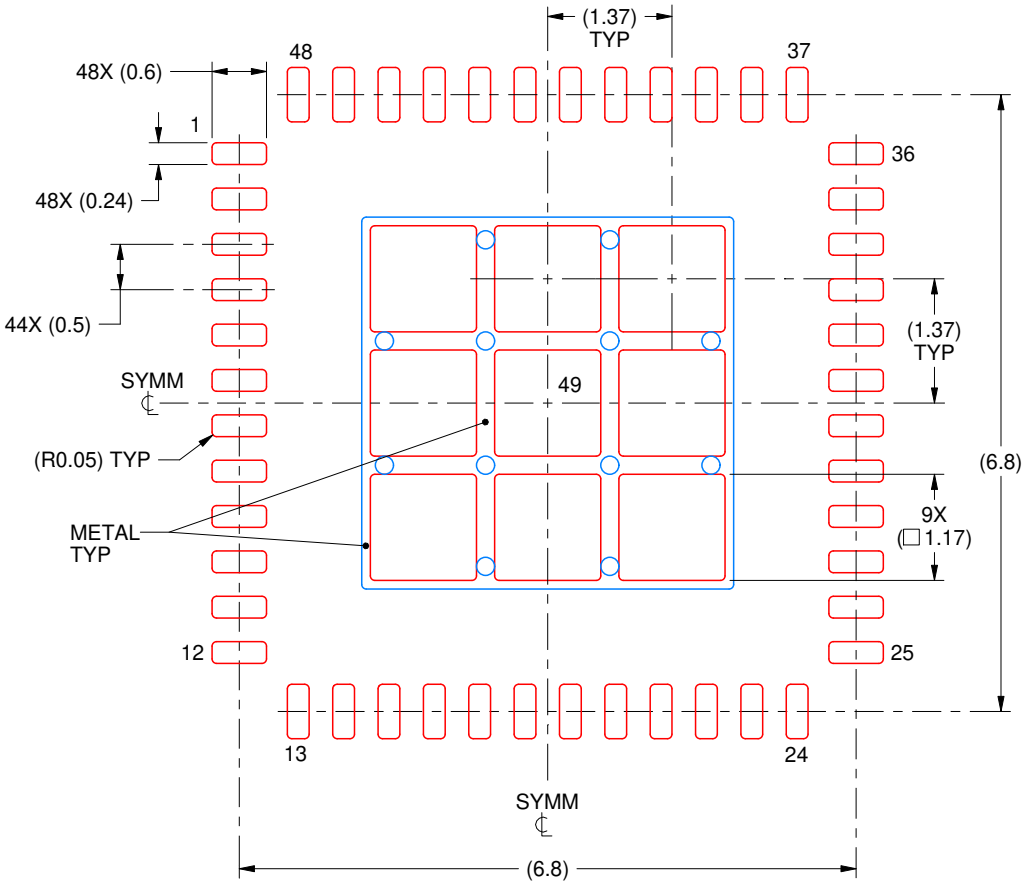


SOLDER MASK DETAILS

4218795/B 02/2017

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 49
73% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:12X

4218795/B 02/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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